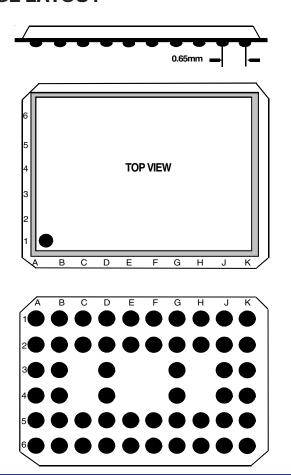
PIN CONFIGURATION

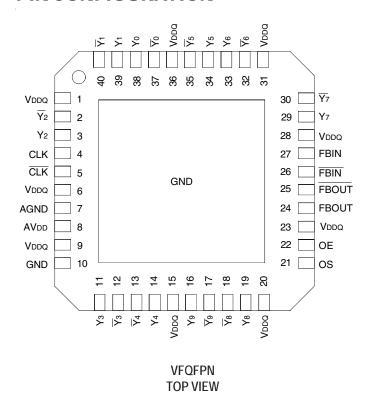
6	Y6	<u>Y6</u>	Y 7	Y 7	FBIN	FBIN	FBOUT	FBOUT	Y 8	<u>Y8</u>
5	Y 5	GND	GND	os	VDDQ	OE	VDDQ	GND	GND	Y 9
4	<u>Y</u> 5	GND	NB	VDDQ	NB	NB	VDDQ	NB	GND	Y 9
3	<u>Y</u> 0	GND	NB	VDDQ	NB	NB	VDDQ	NB	GND	Y4
2	Y0	GND	GND	VDDQ	VDDQ	VDDQ	VDDQ	GND	GND	<u>Y4</u>
1	Y1	<u>Y1</u>	Y2	Y 2	CLK	CLK	AGND	AVDD	Y 3	<u>Y</u> 3
	Α	В	С	D	Е	F	G	Н	J	K

VFBGA TOP VIEW

52 BALL VFBGA PACKAGE LAYOUT



PIN CONFIGURATION



ABSOLUTE MAXIMUM RATINGS(1,2)

Symbol	Rating	Max	Unit
Vddq, AVdd	Supply Voltage Range	-0.5 to +2.5	V
VI ⁽³⁾	Input Voltage Range	-0.5 to VDDQ + 0.5	V
Vo(3)	Voltage range applied to any	-0.5 to VDDQ + 0.5	V
	output in the high or low state		
lik	Input clamp current	±50	mA
(VI <0)			
Іок	Output Clamp Current	±50	mA
(Vo <0 or			
Vo > Vddq)			
lo	Continuous Output Current	±50	mA
(Vo =0 to VDDQ)			
VDDQ or GND	Continuous Current	±100	mA
TSTG	Storage Temperature Range	- 65 to +150	°C

NOTES:

- Stresses greater than those listed under ABSOLUTE MAXIMUM RATINGS may cause
 permanent damage to the device. This is a stress rating only and functional operation of
 the device at these or any other conditions above those indicated in the operational
 sections of this specification is not implied. Exposure to absolute maximum rating
 conditions for extended periods may affect reliability.
- The maximum package power dissipation is calculated using a junction temperature of 150°C and a board trace length of 750 mils.
- The input and output negative-voltage ratings may be exceeded if the input and output clamp-current ratings are observed. This value is limited to 2.5V max.

CAPACITANCE(1)

Parameter	Description	Min.	Тур.	Max.	Unit
CIN	Input Capacitance	2	_	3	pF
	VI = VDDQ or GND				
CιΔ	Delta Input Capacitance			0.25	pF
	CLK, CLK, FBIN, FBIN				
CL	Load Capacitance	_	10	_	pF

NOTE:

1. Unused inputs must be held high or low to prevent them from floating.

RECOMMENDED OPERATING CONDITIONS

Symbol	Parameter	Min.	Тур.	Max.	Unit
AV _{DD} ⁽¹⁾	Supply Voltage		VDDQ		V
VDDQ	I/O Supply Voltage	1.7	1.8	1.9	V
TA	Operating Free-Air Temperature	0	_	+70	°C

NOTE:

1. The PLL is turned off and bypassed for test purposes when AVpp is grounded. During this test mode, Vppp remains within the recommended operating conditions and no timing parameters are guaranteed.

PIN DESCRIPTION (VFBGA)

Pin Name	Pin Number	Description
AGND	G1	Ground for 1.8V analog supply
AVDD	H1	1.8V analog supply
CLK, CLK	E1, F1	Differential clock input with a 10K Ω to 100K Ω pulldown resistor
FBIN, FBIN	E6, F6	Feedback differential clock input
FBOUT, FBOUT	G6, H6	Feedback differential clock output
GND	B2 - B5, C2, C5, H2, H5, J2 - J5	Ground
VDDQ	D2 - D4, E2, E5, F2, G2 - G5	1.8V supply
OE	F5	Output Enable
OS	D5	Output Select (tied to GND or VDDa)
<u>Y[0:9]</u>	A3, A4, B1, B6, C1, C6, K1, K2, K5, K6	Buffered output of input clock, CLK
Y[0:9]	A1, A2, A5, A6, D1, D6, J1, J6, K3, K4	Buffered output of input clock, CLK
NB		No Ball

PIN DESCRIPTION (VFQFPN)

Pin Name	Pin Number	Description
AGND	7	Ground for 1.8V analog supply
AVDD	8	1.8V analog supply
CLK, CLK	4, 5	Differential clock input with a $10 K\Omega$ to $100 K\Omega$ pulldown resistor
FBIN, FBIN	26,27	Feedback differential clock input
FBOUT, FBOUT	24,25	Feedbackdifferential clock output
GND	10	Ground
VDDQ	1, 6, 9, 15, 20, 23, 28, 31, 36	1.8V supply
OE	22	Output Enable
OS	21	Output Select (tied to GND or VDDQ)
Y[0:9]	3, 11, 14, 16, 19, 29, 33, 34, 38, 39	Buffered output of input clock, CLK
Y[0:9]	2, 12, 13, 17, 18, 30, 32, 35, 37, 40	Buffered output of input clock, CLK

FUNCTION TABLE(1,2)

INPUTS OUTPUTS									
AVDD	OE	OS	CLK	CLK	Υ	Ÿ	FBOUT	FBOUT	PLL
GND	Н	Х	L	Н	L	Н	L	Н	OFF
GND	Н	Х	Н	L	Н	L	Н	L	OFF
GND	L	Н	L	Н	L(z)	L(z)	L	Н	OFF
					L(z)	L(z)			
GND	L	L	Н	L	Y 7	Y 7	Н	L	OFF
					Active	Active			
1.8V (nom)	L	Н	L	Н	L(z)	L(z)	L	Н	ON
					L(z)	L(z)			
1.8V (nom)	L	L	Н	L	Y 7	Y 7	Н	L	ON
					Active	Active			
1.8V (nom)	Н	Х	L	Н	L	Н	L	Н	ON
1.8V (nom)	Н	Х	Н	L	Н	L	Н	L	ON
1.8V (nom)	Х	Х	L ⁽³⁾	L ⁽³⁾	L(z)	L(z)	L(z)	L(z)	OFF
Х	Х	Х	Н	Н	Reserved				

NOTES:

- 1. H = HIGH Voltage Level
 - L = LOW Voltage Level
 - X = Don't Care
- 2. L(z) means the outputs are disabled to a LOW state, meeting the looL limit in DC Electrical Characteristics table.
- 3. The device will enter a low power-down mode when CLK and CLK are both at logic LOW.

DC ELECTRICAL CHARACTERISTICS OVER OPERATING RANGE

Following Conditions Apply Unless Otherwise Specified:

Commercial: $TA = 0^{\circ}C$ to $+70^{\circ}C$

Symbol	Parameter		Conditions	Min.	Тур.	Max.	Unit
Vik	Input Clamp Voltage (All Inputs)		VDDQ = 1.7V, II = -18mA	_	_	-1.2	V
VIL ⁽²⁾	Input LOW Voltage (OE, OS	, CLK, CLK)		_	_	0.35VDDQ	V
VIH ⁽²⁾	Input HIGH Voltage (OE, O	S, CLK, CLK)		0.65Vddq	_	_	
VIN ⁽¹⁾	Input Signal Voltage			-0.3	_	VDDQ + 0.3	V
VID(DC) ⁽²⁾	DC Input Differential Voltage			0.3		VDDQ + 0.4	V
Vod ⁽³⁾	Output Differential Voltage		AVDD/VDDQ = 1.7V	0.5	_	_	V
Voн	Output HIGH Voltage		IOH = -100μA, VDDQ = 1.7V to 1.9V	VDDQ - 0.2		_	V
			IOH = -9mA, VDDQ = 1.7V	1.1		_	
Vol	Output LOW Voltage		IOL = 100μA, VDDQ = 1.7V to 1.9V			0.1	V
			IOL = 9mA, VDDQ = 1.7V			0.6	
IODL	Output Disabled LOW Currer	t	OE = L, Vodl = 100mV, Avdd/Vddq = 1.7V	100	_	_	μΑ
liN	Input Current CLK, CLK		AVDD/VDDQ = Max., VI = 0V to VDDQ			±250	μΑ
	OE, OS, FBI	N, FBIN				±10	
Iddld	Static Supply Current (IDDQ and IADD)		AVDD/VDDQ = Max., CLK and $\overline{\text{CLK}}$ = GND			500	μΑ
IDD	Dynamic Power Supply Current		AVDD/VDDQ = Max., CLK = 270MHz			300	mA
	(IDDQ and IADD) ^(4,5)						

NOTES:

- 1. VIN specifies the allowable DC excursion of each different output.
- 2. VID is the magnitude of the difference between the input level on CLK and the input level on CLK and The CLK an
- 3. Vod is the magnitude of the difference between the true output level and the complementary level.
- 4. All Outputs are left open (unconnected to PCB).
- 5. Total IDD = IDDD + IADD = FCK * CPD * VDDD, for Cpd = (IDDD + IADD) / (FCK * VDDD) where FCK is the input frequency, VDDD is the Power Dissipation Capacitance.

TIMING REQUIREMENTS

Symbol	Parameter	Min.	Max.	Unit
fclk	Operating Clock Frequency ^(1,2,3)	125	340	MHz
	Application Clock Frequency ^(2,4)	160	340	MHz
toc	Input Clock Duty Cycle	40	60	%
t.	Stabilization Time ⁽⁵⁾	_	15	μs

NOTES:

- 1. 270MHz max clock frequency for parts assembled and tested prior to WW37.
- 2. The PLL will track a spread spectrum clock input.
- 3. Operating clock frequency is the range over which the PLL will lock, but may not meet all timing specifications. To be used only for low speed system debug.
- 4. Application clock frequency is the range over which timing specifications apply.
- 5. Stabilization time is the time required for the integrated PLL circuit to obtain phase lock of its feedback signal to its reference signal after power up. During normal operation, the stabilization time is also the time required for the PLL circuit to obtain phase lock of its feedback signal to its reference signal when CLK and CLK go to a logic LOW state, enters the power-down mode, and later return to active operation. CLK and CLK may be left floating after they have been driven LOW for one complete clock cycle.

AC ELECTRICAL CHARACTERISTICS(1)

Symbol	Description	Test Conditions	Min.	Typ. ⁽²⁾	Max.	Unit
tPLH ⁽²⁾	LOW to HIGH Level Propagation Delay Time	AVDD = GND, OE = H, OS = L,		TBD		ns
		CLK to any output				
t _{PHL} (2)	HIGH to LOW Level Propagation Delay Time	AVDD = GND, OE = H, OS = L,		TBD		ns
		CLK to any output				
tjit(cc+)	Jitter (cycle-to-cycle)	166/200/266MHz	0		40	ps
tiit(cc-)			0		-40	ı
tjit(per) ⁽³⁾	Jitter (period)	166/200/266MHz	-40		40	ps
tjit(HPER) ⁽³⁾	Half-Period Jitter	166/200/266MHz	-60		60	ps
tslr(0) ^(1,4)	Output Clock Slew Rate (single-ended)	166/200/266MHz (20% to 80%)	1.5	2.5	3	V/ns
tslr(1) ^(1,4)	Output Enable (OE)		0.5	_		V/ns
	Input Clock Slew Rate		1	2.5	4	ı
t(⊘) ⁽⁵⁾	Static Phase Offset	166/200/266MHz	-50		50	ps
t(∅)DYN	Dynamic Phase Offset		TBD		TBD	
tsk(o)	Output Skew				40	ps
ten	Output Enable to any Y or \overline{Y}				8	ns
tdis	Output Disable to any Y or \overline{Y}				8	ns
Vox ⁽⁶⁾	AC Differential Output Crosspoint Voltage	Differential outputs terminated with 120Ω	(VDDQ/2)-0.1		(VDDQ/2)+0.1	V
VID(AC)	AC Differential Input Voltage		0.6		VDDQ+0.4	V
Vıx	AC Differential Input Crosspoint Voltage		(VDDQ/2)-0.15		(VDDQ/2)+0.15	V
The PLL on th	ne CSPU877 will meet all the above test parameters v	vhile supporting SSC synthesizers with the foll	owing parameters	:	•	
SSC	Modulation Frequency		30	_	33	KHz
SSC	Clock Input Frequency Deviation		0	_	-0.5	%
f3dB	PLL Loop Bandwidth		2			MHz

NOTES

- There are two different terminations that are used with the above AC tests. The output load shown in figure 1 is used to measure the input and output differential pair cross-voltage only. The output load shown in figure 2 is used to measure all other tests, including input and output slew rates. For consistency, use 50Ω equal length cables with SMA connectors on the test board.
- 2. Refers to transition of non-inverting output.
- 3. Period jitter and half-period jitter specifications are seperate specifications that must be met independently of each other.
- 4. To eliminate the impact of input slew rates on static phase offset, the input slew rates of reference clock input (CLK, CLK) and feedback clock input (FBIN, FBIN) are recommended to be nearly equal. The 2.5V/ns slew rates are shown as a recommended target. Compliance with these nominal values is not mandatory if it can be adequately demonstrated that alternative characteristics meet the requirements of the registered DDR2 DIMM application.
- 5. Static phase offset does not include jitter.
- 6. Vox is specified at the DDR DRAM clock input or test load.

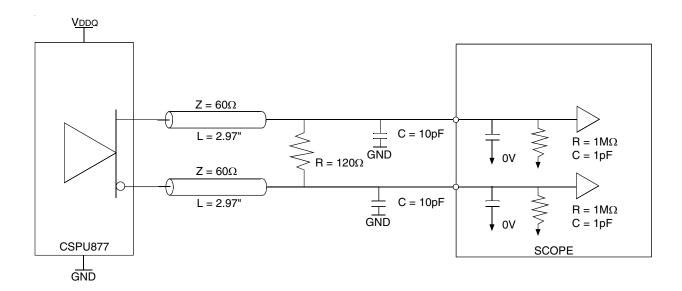


Figure 1: Output Load Test Circuit 1

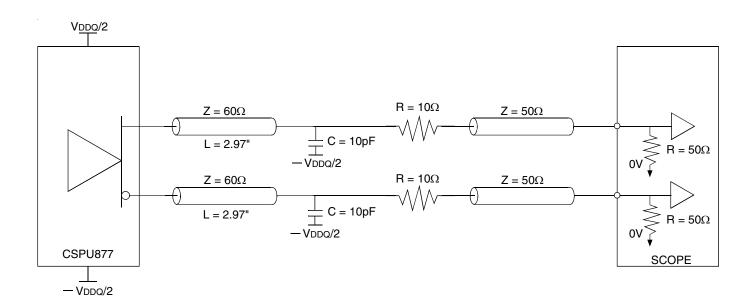
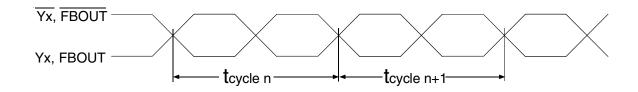
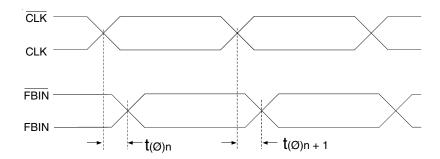


Figure 2: Output Load Test Circuit 2



$$t_{jit(cc)} = t_{cycle n} - t_{cycle n+1}$$

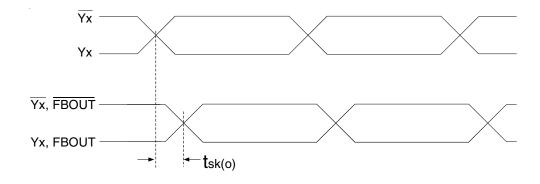
Cycle-to-Cycle jitter



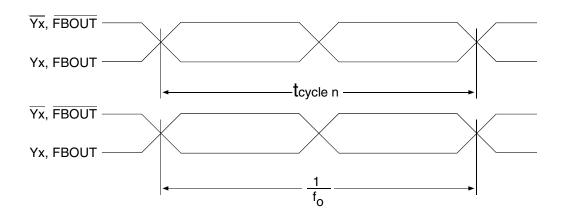
$$t(\emptyset) = \frac{\sum_{1}^{n=N} t(\emptyset)n}{N}$$

(N is a large number of samples)

Static Phase Offset



Output Skew



$$t_{jit(per)} = t_{cycle n} - \frac{1}{f_0}$$

NOTE:

fo = Average input frequency measured at CLK / CLK

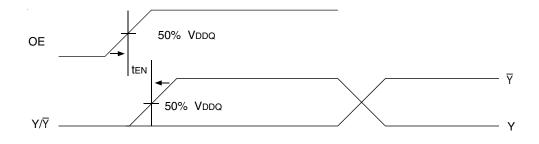
Period jitter

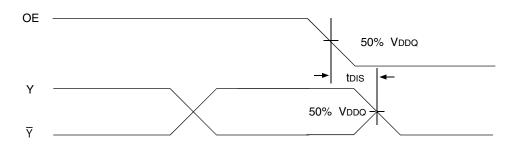
$$\overline{Yx}$$
, \overline{FBOUT}
 \overline{Yx} , \overline

NOTE:

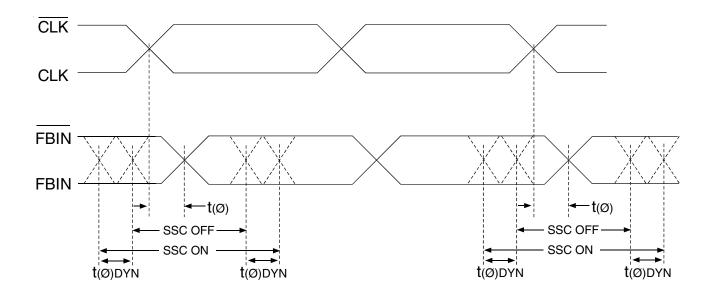
fo = Average input frequency measured at CLK / $\overline{\text{CLK}}$

Half-Period jitter

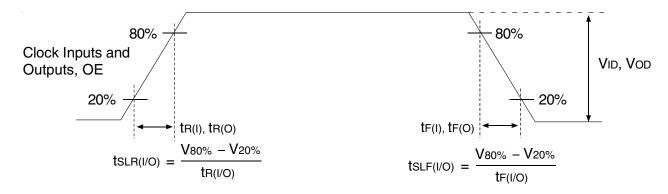




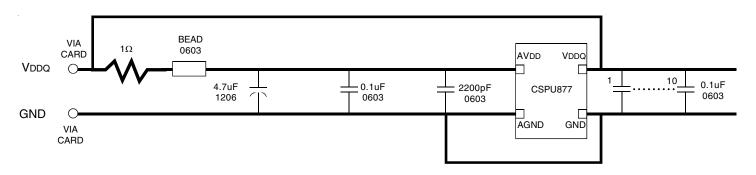
Time Delay Between Output Enable (OE) and Clock Output (Y, \overline{Y})



Dynamic Phase Offset



Input and Output Slew Rates



NOTES:

Place all decoupling capacitors as close to the CSPU877 pins as possible.

Use wide traces for AVDD and AGND.

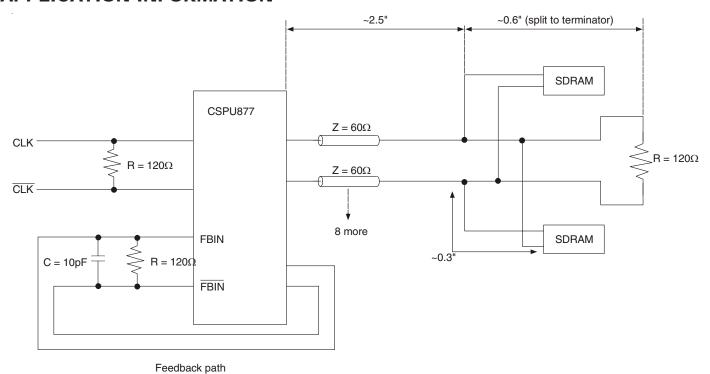
Recommended bead: Fair-rite P/N 2506036017Y0 or equivalent (0.8 Ω DC max., 600 Ω at 100MHz).

Recommended Filtering for the Analog and Digital Power Supplies (AVDD and VDDD)

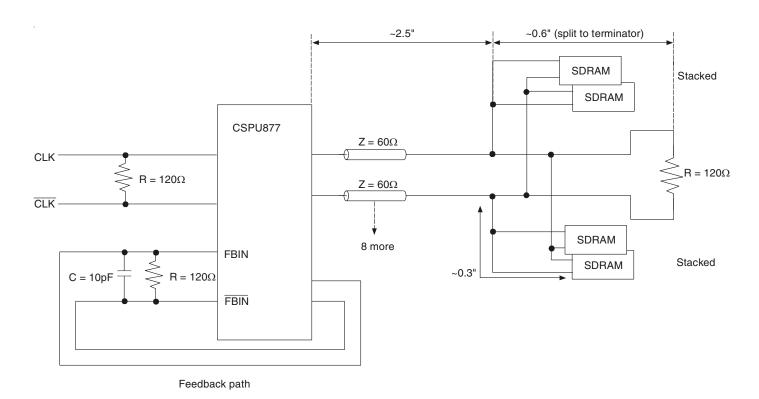
APPLICATION INFORMATION

		Clock Loading on the PLL outputs (pF)		
Clock Structure	# of SDRAM Loads per Clock	Min.	Max.	
#1	2	3	5	
#2	4	6	10	

APPLICATION INFORMATION

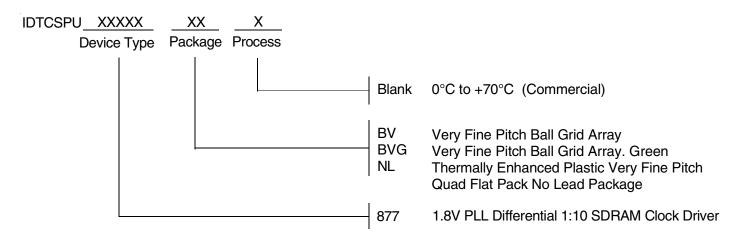


Clock Structure 1



Clock Structure 2

ORDERING INFORMATION



IMPORTANT NOTICE AND DISCLAIMER

RENESAS ELECTRONICS CORPORATION AND ITS SUBSIDIARIES ("RENESAS") PROVIDES TECHNICAL SPECIFICATIONS AND RELIABILITY DATA (INCLUDING DATASHEETS), DESIGN RESOURCES (INCLUDING REFERENCE DESIGNS), APPLICATION OR OTHER DESIGN ADVICE, WEB TOOLS, SAFETY INFORMATION, AND OTHER RESOURCES "AS IS" AND WITH ALL FAULTS, AND DISCLAIMS ALL WARRANTIES, EXPRESS OR IMPLIED, INCLUDING, WITHOUT LIMITATION, ANY IMPLIED WARRANTIES OF MERCHANTABILITY, FITNESS FOR A PARTICULAR PURPOSE, OR NON-INFRINGEMENT OF THIRD PARTY INTELLECTUAL PROPERTY RIGHTS.

These resources are intended for developers skilled in the art designing with Renesas products. You are solely responsible for (1) selecting the appropriate products for your application, (2) designing, validating, and testing your application, and (3) ensuring your application meets applicable standards, and any other safety, security, or other requirements. These resources are subject to change without notice. Renesas grants you permission to use these resources only for development of an application that uses Renesas products. Other reproduction or use of these resources is strictly prohibited. No license is granted to any other Renesas intellectual property or to any third party intellectual property. Renesas disclaims responsibility for, and you will fully indemnify Renesas and its representatives against, any claims, damages, costs, losses, or liabilities arising out of your use of these resources. Renesas' products are provided only subject to Renesas' Terms and Conditions of Sale or other applicable terms agreed to in writing. No use of any Renesas resources expands or otherwise alters any applicable warranties or warranty disclaimers for these products.

(Rev.1.0 Mar 2020)

Corporate Headquarters

TOYOSU FORESIA, 3-2-24 Toyosu, Koto-ku, Tokyo 135-0061, Japan www.renesas.com

Trademarks

Renesas and the Renesas logo are trademarks of Renesas Electronics Corporation. All trademarks and registered trademarks are the property of their respective owners.

Contact Information

For further information on a product, technology, the most up-to-date version of a document, or your nearest sales office, please visit:

www.renesas.com/contact/

Mouser Electronics

Authorized Distributor

Click to View Pricing, Inventory, Delivery & Lifecycle Information:

Renesas Electronics:

CSPU877BVG8 CSPU877BVG